


<b>Search Notes</b>  	<b>Application/Control No.</b>  10774594	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  MARK A RADTKE	<b>Art Unit</b>  2165

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
Updated search	5/20/2008	maxr
Double patenting search	5/20/2008	maxr
Consulted SPE Christian Chace regarding allowable subject matter	5/20/2008	maxr
limited keyword search on subclasses 707/100-102	5/20/2008	maxr

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
707	100-102 with limited keyword	5/20/2008	maxr